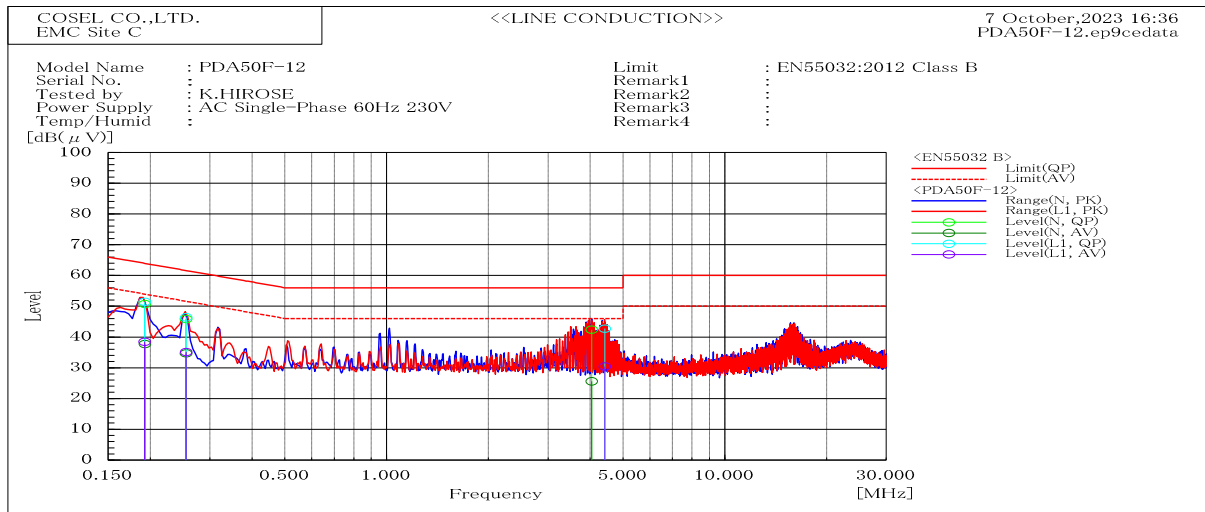
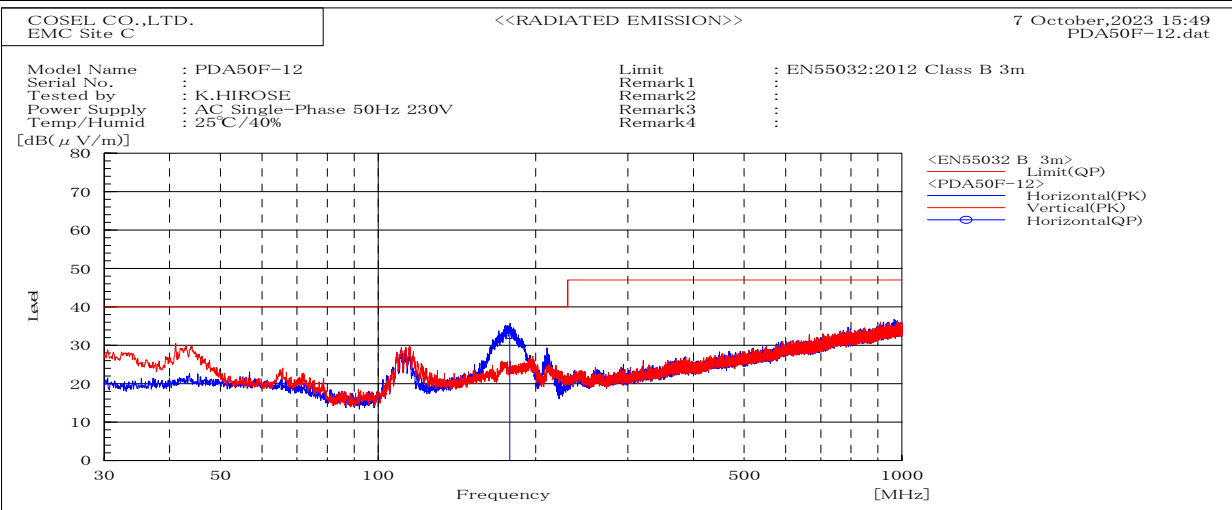


DATA SHEET		Date	02-Dec-23
Model	PDA50F-12	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	K.HIROSE



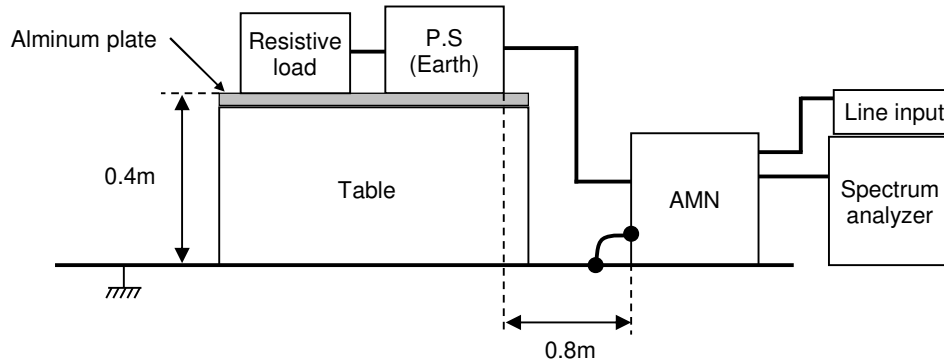
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.193	N	50.7	37.8	63.9	53.9	13.2	16.1	Pass	
0.255	N	45.8	34.7	61.6	51.6	15.8	16.9	Pass	
4.037	N	42.4	25.6	56	46	13.6	20.4	Pass	
0.192	L1	51.5	38.5	63.9	53.9	12.4	15.4	Pass	
0.255	L1	46.4	35.2	61.6	51.6	15.2	16.4	Pass	
4.415	L1	42.7	30.4	56	46	13.3	15.6	Pass	



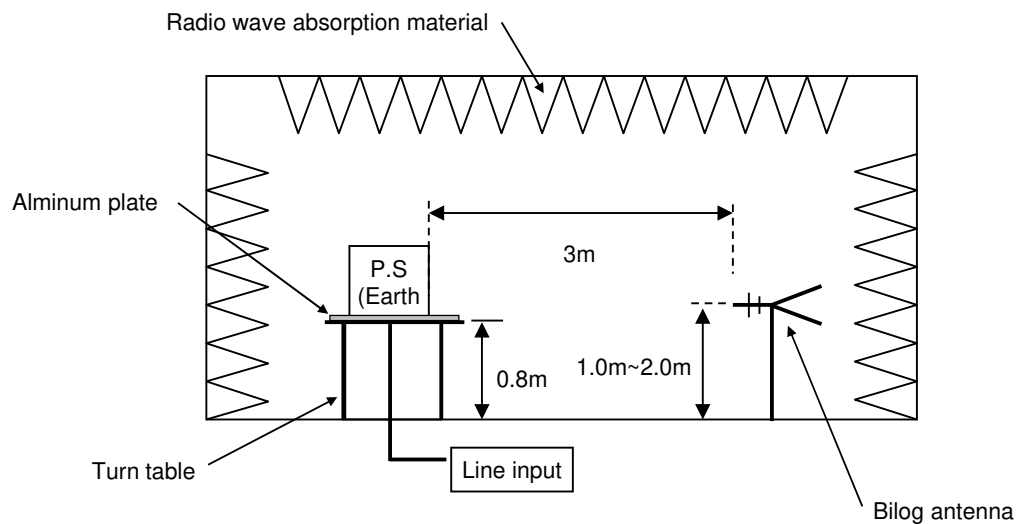
Frequency MHz	Polarization	Stability	Level dB(μV/m)	Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP	QP				
178.451	H	Stable	32.7	40	7.3	Pass	199.7	336	

DATA SHEET		Date	02-Dec-23
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	K.HIROSE

### 1. Line conduction



### 2. Radiated emission



**Conditions**

Test : EMI  
Model Nam: PDA50F-12

**1.LINE CONDUCTION****2.RADIATED EMISSION**